

TEM analysis of nanowires
A. Travlos
Institute of Materials Science, NCSR “DEMOKRITOS”
Athens, Greece

Abstract

Transmission Electron Microscopy is a powerful tool, well suited for the investigation of the properties of nanomaterials. The crystalline structure, morphology, growth mechanisms, chemical composition and optical properties are some of the properties of the nanomaterials that can be studied by TEM. Examples of these investigations will be presented for the case of ZnO nanowires.